

The 1st International Round-Robin on Bi-Facial Modules

M. Pravettoni, C. Deline, G. Arnoux, K. Berger, C. Fell, E. Garcia Goma,

A. Halm, W. Herrmann, D. Hu, M. Joanny, K. Lee, J. Levrat, J. Lopez Garcia,

G. Mei, C. Monokruossos, R. Roldán, A. Schmidt, H. Tobita, B. Van Aken,

L. Votta, S. Wendlandt, and M. Yoshita



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Pre-standard nameplates: example 1



Model Number	-MO-60E	10-60BP-290M		LR6-60BP-295M		LR6-60BP-300M		LR6-60BP-305M		LR6-60BP-310M	
Testing Condition	Front	Back	Front	Back	Front	Back	Front	Back	Front	Back	
Maximum Power (Pmax/W)	220	215	295	222	300	226	305	229	310	233	
Open Circuit Voltage (Voc/V)	39.2	38.9	39.4	39.1	39.6	39.3	39.8	39.5	40.0	39.7	
Short Circuit Current (Isc/A)	9.36	7.16	9.47	7.25	9.58	7.33	9.69	7.42	9.80	7.50	
Voltage at Maximum Power (Vmp/V)	32.6	33.3	32.7	33.5	32.9	33.7	33.1	33.8	33.2	34.0	
Current at Maximum Power (Imp/A)	8.90	6.54	9.01	6.63	9.11	6.71	9.22	6.77	9.33	6.85	
Module Efficiency(%)	17.5	13.1	17.8	13.4	18.1	13.6	18.4	13.8	18.7	14.0	

Electrical characteristics with different rear side power gain (reference to 300W front)

Pmax /W	Voc/V	Isc /A	Vmp/V	Imp /A	Pmax gain	
315	39.6	9.94	32.9	9.58	5%	
330	39.6	10.40	32.9	10.04	10%	
360	39.7	11.35	32.8	10.98	20%	
375	39.7	11.82	32.8	11.44	25%	

- STC from both sides
- Electrical characteristics with typical bifi power gains





Pre-standard nameplates: example 2



Module Type	JKM295N	Л-60-BDV	JKM300N	M-60-BDV	JKM305N	M-60-BDV	JKM310N	1-60-BDV	JKM315N	N-60-BDV
	STC	NOCT	STC	NOCT	STC	NOCT	STC	NOCT	STC	NOCT
Maximum Power (Pmax)	295Wp	219Wp	300Wp	223Wp	305Wp	227Wp	310Wp	230Wp	315Wp	234Wp
Maximum Power Voltage (Vmp)	32.1V	29.2V	32.3V	29.4V	32.5V	29.6V	32.7V	29.7V	32.9V	29.9V
Maximum Power Current (Imp)	9.20A	7.51A	9.30A	7.59A	9.39A	7.68A	9.49A	7.75A	9.58A	7.82A
Open-circuit Voltage (Voc)	39.3V	36.2V	39.5V	36.4V	39.7V	36.6V	39.9V	36.7V	40.1V	37.8V
Short-circuit Current (Isc)	9.82A	7.95A	9.92A	8.03A	10.02A	8.12A	10.11A	8.18A	10.21A	8.27A
Module Efficiency STC (%)	17.6	66%	17.9	96%	18.2	26%	18.5	66%	18.8	35%
Operating Temperature(°C)					-40°C~	+85°C				
Maximum system voltage					1500VD	C (IEC)				
Maximum series fuse rating					20)A				
Power tolerance					0~+3%					
emperature coefficients of Pmax					-0.38%/°C					
emperature coefficients of Voc					-0.28	3%/°C				
Temperature coefficients of Isc					0.048	8%/°C				
Nominal operating cell temperature	(NOCT)				46:	±2°C				
Refer. Bifacial Factor					90-	±3%				

Only STC values, front side (though not specified)









Pre-standard nameplates: example 3



ELECTRICAL PARAMETERS

		JNHM60-340	JNHM60-345	JNHM60-350	JNHM60-355	JNHM60-360
	Max. Power at BSTC (Pmpp/W)	340	345	350	355	360
	Output Tolerance (W)	0~+5	0~+5	0~+5	0~+5	0~+5
ветс	Max. Power Voltage (Vmp/V)	36.10	36.28	36.50	36.72	36.93
M1.5, E=(1+0.135BiFi) 1000W/m²	lax. Power Current (Imp/A)	9.42	9.51	9.59	9.67	9.75
ell Temperature 25°C	Open Circuit Voltage (Voc/V)	42.72	43.01	43.29	43.57	43.84
	Short Circuit Current (Isc/A)	9.93	9.99	10.03	10.07	10.12
	Module Efficiency (%)	20.7	21.0	21.3	21.6	21.9
	Max. Power at STC (Pmpp/W)	305	310	315	320	325
STC	Max. Power Voltage (Vmp/V)	35.83	36.06	36.25	36.49	36.70
AM1.5, 1000W/m² Cell Temperature 25°C	lax. Power Current (Imp/A)	8.52	8.60	8.69	8.77	8.86
	Open Circuit voltage (Voc/V)	42.30	42.54	42.82	43.10	43.38
	Short Circuit Current (Isc/A)	8.91	8.95	9.00	9.04	9.08

Both STC and "BSTC" values





IEC TS 60904-1-2 almost ready!



January 2019 publication date, final vote approved

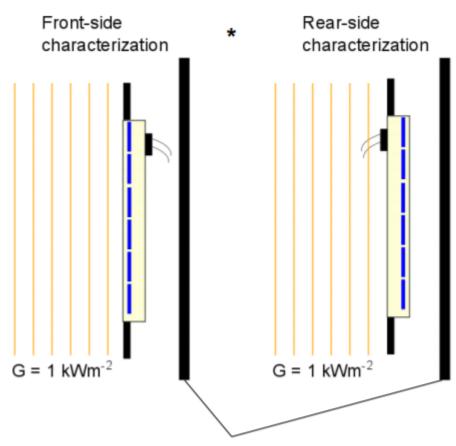
Step 1: Bifaciality measurement

$$\varphi_{Isc} = \frac{Isc_r}{Isc_f}$$

$$\varphi_{Voc} = \frac{Voc_r}{Voc_f}$$

$$\boldsymbol{\varphi}_{Pmax} = \frac{Pmax_r}{Pmax_f}$$

$$\varphi = Min(\varphi_{Isc}, \varphi_{Pmax})$$



Non-irradiated background

V. Fakhfouri, bifiPV workshop, October 2017 Konstanz DE

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IEC TS 60904-1-2 almost ready!



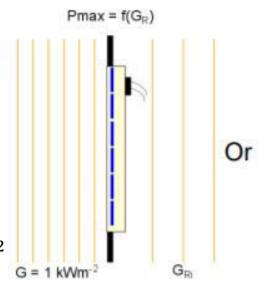
Step 2: Bifacial Gain determination

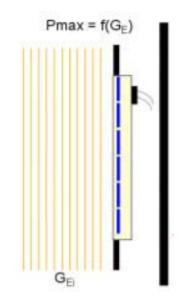
• Dual simultaneous illumination, or single-side at equivalent irradiance levels G_{E_i} :

$$G_{E_i} = 1000 \ Wm^{-2} + \varphi \cdot G_{R_i}$$
 $\varphi = Min(\varphi_{Isc}, \varphi_{Pmax})$

• Example for φ = 80%,

$$G_{R_1} = 100 Wm^{-2}$$
 $G_{R_2} = 200 Wm^{-2}$
 $\Rightarrow G_{E_1} = 1080 Wm^{-2}$ $\Rightarrow G_{E_2} = 1160 Wm^{-2}$





V. Fakhfouri, bifiPV workshop, October 2017 Konstanz DE



IEC TS 60904-1-2 almost ready!



Step 3: To report

- Bifaciality coefficients: φ_{Isc} , φ_{Voc} , and φ_{Pmax}
- I_{sc} , V_{oc} , and P_{max} as a function of the rear side irradiance G_R or equivalent irradiance $G_E = 1000 + \varphi \cdot G_R$
- The power gain yield (i.e. the slope of P_{max} vs G_R)
- The power values at G_R =100 W/m² and G_R =200 W/m² : $P_{maxBiFi10}$ and $P_{maxBiFi20}$
- Values at STC from both sides





Motivation for the 1st BiFi RR



ISO/IEC 17025:2017

7.2.2 Validation of methods

7.2.2.1 The laboratory shall validate non-standard methods, laboratory-developed methods and standard methods used outside their intended scope or otherwise modified.

NOTE 2 The techniques used for method validation can be one of, or a combination of, the following:

[...]

e) Interlaboratory comparisons;

7.7 Ensuring the validity of results

- **7.7.2** The laboratory **shall monitor its performance** by comparison with results of other laboratories, where available and appropriate. This monitoring shall be planned and reviewed and shall include, either or both of the following:
- (a) Participation in proficiency testing; [...]





Participants to the 1st BiFi RR



ISO 17025 accre	Non-accredited laboratories	
NREL ■ JRC □ Fraunhofer-ISE ■ TÜV-Rheinland ■ AIST •	SERIS (coordinator) Kiwa SUPSI CEA-INES PI-Berlin PI-China CPVT JET AIT CFV CFV	Pasan ☐ CSEM-EPFL ☐ CSIRO ☐ ISC ☐ ECN-TNO ☐ Eternal Sun ☐
Group 1	Group 2	Group 3





Testing samples















LONGI Solar





monofacial (REFERENCE)						
P-type PERC	poly-Si	P-type PERC	НЈТ	N-type PERT	P-type PERC	N-type PERT	poly-Si
2 samples	2 samples	2 samples	2 samples	2 samples	2 samples	2 samples	2 samples
60 cells	60 cells	60 cells	60 cells	60 cells	72 cells	120 cells HC	144 cells HC
Frame	Frame	Frame	No frame	Frame	Frame	No frame	No frame

SINGAPORE

Shipment

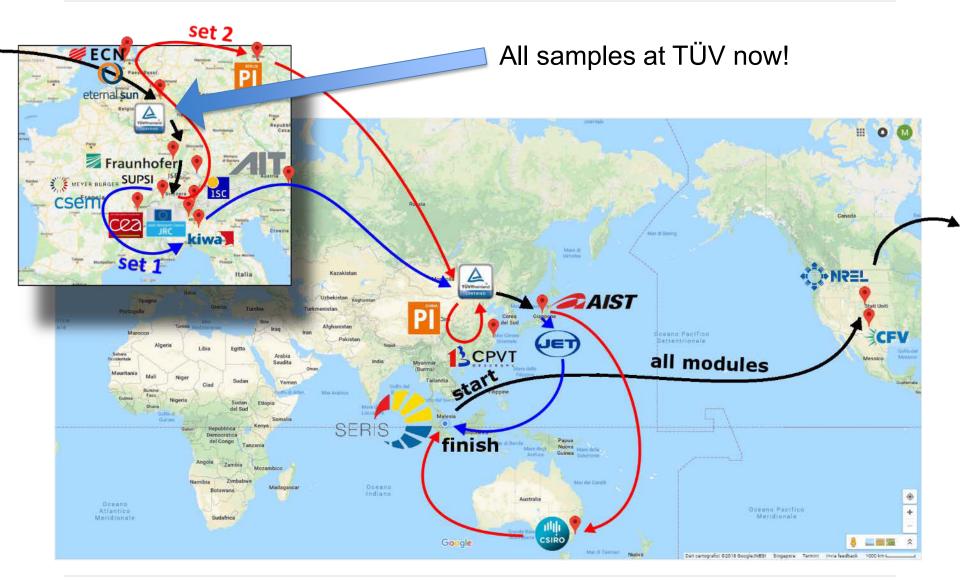






The circulating path







What to measure

Electrical parameters to be reported as per IEC TS 60904-1-2:

Measurand	Units	Comment
Bifaciality coefficient, φ_{Isc}	[-]	
Bifaciality coefficient, φ_{Pmax}	[-]	
Bifaciality coefficient, φ_{Voc}	[-]	
Bifaciality coefficient, $\varphi = \min(\varphi_{lsc}, \varphi_{Pmax})$	[-]	
I_{sc} at $G_E = 1000 \text{ W/m}^2$	Α	
I_{sc} at $G_E = 1000 + 100 \varphi$ W/m ²	Α	
I_{sc} at $G_E = 1000 + 200 \varphi$ W/m ²	Α	Optional
V_{oc} at $G_E = 1000 \text{ W/m}^2$	V	
V_{oc} at $G_E = 1000 + 100 \varphi$ W/m ²	V	
V_{oc} at $G_E = 1000 + 200 \varphi$ W/m ²	V	Optional
P_{max} at $G_E = 1000 \text{ W/m}^2$	W	
P_{max} at $G_E = 1000 + 100 \varphi$ W/m ²	W	
P_{max} at $G_E = 1000 + 200 \varphi$ W/m ²	W	Optional
I_{sc} of the rear side, STC	Α	
V_{oc} of the rear side, STC	V	
P_{max} of the rear side, STC	W	
I_{sc} of the rear side at 100 and 200 W/m ²	Α	Optional
V_{oc} of the rear side at 100 and 200 W/m ²	V	Optional
P_{max} of the rear side at 100 and 200 W/m ²	W	Optional
SR of the front side	A/W	Optional
SR of the rear side	A/W	Optional
Mismatch factor to the front side at 1000 W/m ²	[-]	Optional
Mismatch factor to the back side at 1000 W/m ²	[-]	Optional
Slope ¹ of P_{max} vs G_E	m ²	





Statistical design: Proficiency Testing (PT) SERIS



ISO 17043

Monofacial Modules (reference):

To calculate:

•
$$z_i = \frac{x_i - x_{PT}}{\sigma_{PT}(x)}$$
 the "z-score" All laboratories

•
$$E_{n,i} = \frac{x_i - x_{PT}}{\sqrt{U^2(x_i) + U^2(x_{PT})}}$$
 the " E_n -score" Only Groups 1 & 2

where:

- x_{PT} is the robust average from the labs of Group 1 (assigned value)
- σ_{PT} is the robust standard deviation (**PT st dev**)

Bifacial Modules (acceptance criterium):

Groups 1 & 2 labs with $|E_n| < 0.5$ on monofacial will set the assigned values x_{PT} and σ_{PT} for bifacial modules...







Statistical design: Proficiency Testing (PT) SERIS

SERIS

ISO 17043

$$z_i = \frac{x_i - x_{PT}}{\sigma_{PT}(x)}$$

the "z-score"

All laboratories

•
$$E_{n,i} = \frac{x_i - x_{PT}}{\sqrt{U^2(x_i) + U^2(x_{PT})}}$$

the " E_n -score"

Only Group 1 & 2

Z	\leq	2.	0	

(satisfactory)

The PT is satisfactory

 $E_n \leq 1.0$ (satisfactory)

Action: none

The claimed uncertainty is too low, but the result fills the requirements of the P1

 $E_n > 1.0$ (unsatisfactory)

Action: check uncertainty

z>2.0 (unsatisfactory)

The result is within the claimed uncertainty, but not within the limits of the PT

Action: check procedure

The result is too much biased and the reason should be clarified

Action: check uncertainty & procedure



Conclusions



- Importance of aligning to an agreed international standard
- IEC TS 60904-1-2 almost available: congratulations to Vahid Fakhfouri & team for the precious work
- 1st International RR on commercial BiFi modules to assess reproducibility is ongoing
- See you to bifiPV 2019 for results!





Acknowledgements



For providing samples to be tested:











For taking part to the round robin:

















eternal sun





















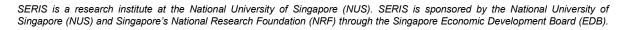














Thank you for your attention!

More information mauro.pravettoni@nus.edu.sg



